## Notice of References Cited Application/Control No. 10/079,120 Examiner Tran N. Nguyen Applicant(s)/Patent Under Reexamination NADEAU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-4,181,472	01-1980	Sharp, Bernard C.	417/363
人	В	US-4,651,066	03-1987	Gritter et al.	318/139
X	O	US-5,959,379	09-1999	Hu et al.	310/51
X	D	US-5,861,694	01-1999	Niemela, Paul W.	310/89
X	Е	US-3,773,285	11-1973	Morrill, Wayne J.	248/603
X	F	US-5,492,456	02-1996	Knight et al.	417/360
X	G	US-6,076,795	06-2000	Scheidel et al.	248/603
X	Ξ	US-5,953,932	09-1999	Kwon, Hyuk-Jang	62/297
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Ъ					
	Q					
	R					
	S					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.